



# THE DATASHEET OF LP2980AIM5X-5.0

# LP2980-N Micropower, 50-mA, Ultra-Low-Dropout Regulator in SOT-23 Package

## 1 Features

- $V_{IN}$  range (new chip): 2.5 V to 16 V
- $V_{OUT}$  range (new chip):
  - 1.2 V to 5.0 V (fixed, 100-mV steps)
- $V_{OUT}$  accuracy:
  - $\pm 0.5\%$  for A-grade legacy chip
  - $\pm 1\%$  for standard-grade legacy chip
  - $\pm 0.5\%$  for new chip (A grade and standard grade)
- Output accuracy over load, and temperature:  $\pm 1\%$  (new chip)
- Output current: Up to 50 mA
- Low  $I_Q$  (new chip): 69  $\mu A$  at  $I_{LOAD} = 0$  mA
- Low  $I_Q$  (new chip): 380  $\mu A$  at  $I_{LOAD} = 50$  mA
- Shutdown current over temperature:
  - 0.01  $\mu A$  (typ) for legacy chip
  - 1.12  $\mu A$  (typ) for new chip
- Output current limiting and thermal protection
- Stable with 2.2- $\mu F$  ceramic capacitors (new chip)
- High PSRR (new chip):
  - 75 dB at 1 kHz, 45 dB at 1 MHz
- Operating junction temperature:  $-40^{\circ}C$  to  $+125^{\circ}C$
- Package: 5-pin SOT-23 (DBV)

## 2 Applications

- [Residential breakers](#)
- [Solid state drives \(SSD\)](#)
- [Electricity meters](#)
- [Appliances](#)
- [Building automation](#)

## 3 Description

The LP2980-N is a fixed-output, wide-input, low-dropout (LDO) voltage regulator supporting an input voltage range from 2.5 V to 16 V and up to 50 mA of load current. The LP2980-N supports an output range of 1.2 V to 5.0 V (new chip).

Additionally, the LP2980-N (new chip) has a 1% output accuracy across load and temperature that can meet the needs of low-voltage microcontrollers (MCUs) and processors.

In the new chip, wide bandwidth PSRR performance is 75 dB at 1 kHz and 45 dB at 1 MHz to help attenuate the switching frequency of an upstream DC/DC converter and minimize post regulator filtering.

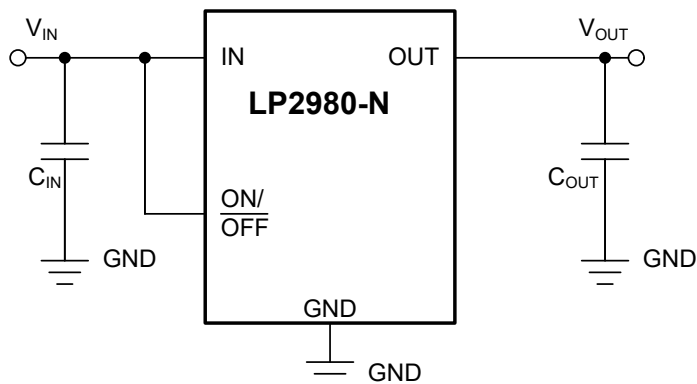
The internal soft-start time and current-limit protection reduce inrush current during start up, thus minimizing input capacitance. Standard protection features, such as overcurrent and overtemperature protection, are included.

The LP2980-N is available in a 5-pin, 2.9-mm  $\times$  1.6-mm SOT-23 (DBV) package.

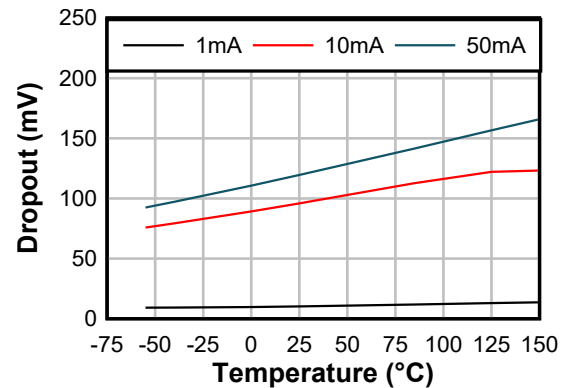
### Package Information

| PART NUMBER | PACKAGE <sup>(1)</sup> | PACKAGE SIZE <sup>(2)</sup> |
|-------------|------------------------|-----------------------------|
| LP2980-N    | DBV (SOT-23, 5)        | 2.9 mm $\times$ 2.8 mm      |

- (1) For more information, see the [Mechanical, Packaging, and Orderable Information](#).
- (2) The package size (length  $\times$  width) is a nominal value and includes pins, where applicable.



Typical Application Circuit



Dropout Voltage vs Temperature (New Chip)



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## 4 Pin Configuration and Functions

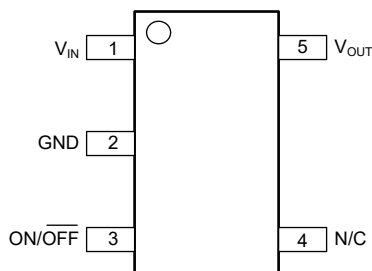


Figure 4-1. DBV Package, 5-Pin SOT-23 (Top View)

Table 4-1. Pin Functions

| PIN |        | TYPE | DESCRIPTION                                                                                                                                                                                                                                       |
|-----|--------|------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NO. | NAME   |      |                                                                                                                                                                                                                                                   |
| 1   | IN     | I    | Input supply pin. Use a capacitor with a value of 1 $\mu$ F or larger from this pin to ground. See the <a href="#">Input and Output Capacitor Requirements</a> section for more information.                                                      |
| 2   | GND    | —    | Common ground (device substrate).                                                                                                                                                                                                                 |
| 3   | ON/OFF | I    | Enable pin for the LDO. Driving the ON/OFF pin high enables the device. Driving this pin low disables the device. High and low thresholds are listed in the <a href="#">Electrical Characteristics</a> table. Tie this pin to $V_{IN}$ if unused. |
| 4   | N/C    | —    | Do not connect.                                                                                                                                                                                                                                   |
| 5   | OUT    | O    | Output of the regulator. Use a capacitor with a value of 2.2 $\mu$ F or larger from this pin to ground <sup>(1)</sup> . See the <a href="#">Input and Output Capacitor Requirements</a> section for more information.                             |

- (1) The nominal output capacitance must be greater than 1  $\mu$ F. Throughout this document, the nominal derating on these capacitors is 50%. Make sure that the effective capacitance at the pin is greater than 1  $\mu$ F.

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1) (2)</sup>

|                     |                                                  | MIN                | MAX                                                  | UNIT |
|---------------------|--------------------------------------------------|--------------------|------------------------------------------------------|------|
| V <sub>IN</sub>     | Continuous input voltage range (for legacy chip) | –0.3               | 16                                                   | V    |
|                     | Continuous input voltage range (for new chip)    | –0.3               | 18                                                   | V    |
| V <sub>OUT</sub>    | Output voltage range (for legacy chip)           | –0.3               | 9                                                    | V    |
|                     | Output voltage range (for new chip)              | –0.3               | V <sub>IN</sub> + 0.3 or 9<br>(whichever is smaller) | V    |
| V <sub>ON/OFF</sub> | ON/OFF pin voltage range (for legacy chip)       | –0.3               | 16                                                   | V    |
|                     | ON/OFF pin voltage range (for new chip)          | –0.3               | 18                                                   | V    |
| Current             | Maximum output                                   | Internally limited |                                                      | A    |
| Temperature         | Operating junction, T <sub>J</sub>               | –55                | 150                                                  | °C   |
|                     | Storage, T <sub>stg</sub>                        | –65                | 150                                                  | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages with respect to GND.

### 5.2 ESD Ratings

|                    |                         |                                                                                | VALUE<br>(Legacy<br>Chip) | VALUE<br>(New<br>Chip) | UNIT |
|--------------------|-------------------------|--------------------------------------------------------------------------------|---------------------------|------------------------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±2000                     | ±3000                  | V    |
|                    |                         | Charged device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±500                      | ±1000                  |      |

- (1) JEDEC document JEP155 states that 2-kV HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 500-V CDM allows safe manufacturing with a standard ESD control process.

### 5.3 Recommended Operating Conditions

|                                |                                                  | MIN | NOM | MAX             | UNIT |
|--------------------------------|--------------------------------------------------|-----|-----|-----------------|------|
| V <sub>IN</sub>                | Supply input voltage (for legacy chip)           | 2.2 |     | 16              | V    |
|                                | Supply input voltage (for new chip)              | 2.5 |     | 16              | V    |
| V <sub>OUT</sub>               | Output voltage (for legacy chip)                 | 1.2 |     | 10.0            | V    |
|                                | Output voltage (for new chip)                    | 1.2 |     | 5               | V    |
| V <sub>ON/OFF</sub>            | Enable voltage (for legacy chip)                 | 0   |     | V <sub>IN</sub> | V    |
|                                | Enable voltage (for new chip)                    | 0   |     | 16              | V    |
| I <sub>OUT</sub>               | Output current                                   | 0   |     | 50              | mA   |
| C <sub>IN</sub> <sup>(1)</sup> | Input capacitor                                  |     | 1   |                 | μF   |
| C <sub>OUT</sub>               | Output capacitor (for legacy chip)               | 2.2 | 4.7 |                 |      |
|                                | Output capacitance (for new chip) <sup>(1)</sup> | 1   | 2.2 | 200             |      |
| T <sub>J</sub>                 | Operating junction temperature                   | –40 |     | 125             | °C   |

- (1) All capacitor values are assumed to derate to 50% of the nominal capacitor value. Maintain an effective output capacitance of 1 μF minimum for stability.

## 5.4 Thermal Information

| THERMAL METRIC <sup>(2)</sup> <sup>(1)</sup> |                                              | Legacy Chip   | New Chip      | UNIT |
|----------------------------------------------|----------------------------------------------|---------------|---------------|------|
|                                              |                                              | DBV (SOT23-5) | DBV (SOT23-5) |      |
|                                              |                                              | 5 PINS        | 5 PINS        |      |
| $R_{\theta JA}$                              | Junction-to-ambient thermal resistance       | 205.4         | 178.6         | °C/W |
| $R_{\theta JC(top)}$                         | Junction-to-case (top) thermal resistance    | 78.8          | 77.9          | °C/W |
| $R_{\theta JB}$                              | Junction-to-board thermal resistance         | 46.7          | 47.2          | °C/W |
| $\Psi_{JT}$                                  | Junction-to-top characterization parameter   | 8.3           | 15.9          | °C/W |
| $\Psi_{JB}$                                  | Junction-to-board characterization parameter | 46.3          | 46.9          | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application note.
- (2) Thermal performance results are based on the JEDEC standard of 2s2p PCB configuration. These thermal metric parameters can be further improved by 35-55% based on thermally optimized PCB layout designs. See the analysis of the [Impact of board layout on LDO thermal performance](#) application report.

## 5.5 Electrical Characteristics

specified at  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(nom)} + 1.0\text{ V}$  or  $V_{IN} = 2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ ,  $V_{ON/OFF} = 2\text{ V}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ , and  $C_{OUT} = 2.2\text{ }\mu\text{F}$  (unless otherwise noted)

| PARAMETER                       |                          | TEST CONDITIONS                                                                                              |                              | MIN   | TYP   | MAX   | UNIT  |
|---------------------------------|--------------------------|--------------------------------------------------------------------------------------------------------------|------------------------------|-------|-------|-------|-------|
| $\Delta V_{OUT}$                | Output voltage tolerance | $I_L = 1\text{ mA}$                                                                                          | Legacy chip (standard grade) | -1.0  |       | 1.0   | %     |
|                                 |                          |                                                                                                              | Legacy chip (A grade)        | -0.5  |       | 0.5   |       |
|                                 |                          |                                                                                                              | New chip                     | -0.5  |       | 0.5   |       |
|                                 |                          | $1\text{ mA} \leq I_L \leq 50\text{ mA}$                                                                     | Legacy chip (standard grade) | -1.5  |       | 1.5   |       |
|                                 |                          |                                                                                                              | Legacy chip (A grade)        | -0.75 |       | 0.75  |       |
|                                 |                          |                                                                                                              | New chip                     | -0.5  |       | 0.5   |       |
|                                 |                          | $1\text{ mA} \leq I_L \leq 50\text{ mA}$ , $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$               | Legacy chip (standard grade) | -3.5  |       | 3.5   |       |
|                                 |                          |                                                                                                              | Legacy chip (A grade)        | -2.5  |       | 2.5   |       |
|                                 |                          |                                                                                                              | New chip                     | -1.0  |       | 1.0   |       |
| $\Delta V_{OUT(\Delta V_{IN})}$ | Line regulation          | $V_{O(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}$                                                       | Legacy chip                  |       | 0.007 | 0.014 | % / V |
|                                 |                          |                                                                                                              | New chip                     |       | 0.002 | 0.014 |       |
|                                 |                          | $V_{O(NOM)} + 1\text{ V} \leq V_{IN} \leq 16\text{ V}$ , $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$ | Legacy chip                  |       | 0.007 | 0.032 |       |
|                                 |                          |                                                                                                              | New chip                     |       | 0.002 | 0.032 |       |

## 5.5 Electrical Characteristics (continued)

specified at  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(nom)} + 1.0\text{ V}$  or  $V_{IN} = 2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ ,  $V_{ON/OFF} = 2\text{ V}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ , and  $C_{OUT} = 2.2\text{ }\mu\text{F}$  (unless otherwise noted)

| PARAMETER          |                                | TEST CONDITIONS                                                                 |             | MIN | TYP   | MAX  | UNIT |
|--------------------|--------------------------------|---------------------------------------------------------------------------------|-------------|-----|-------|------|------|
| $V_{IN} - V_{OUT}$ | Dropout voltage <sup>(1)</sup> | $I_{OUT} = 0\text{ mA}$                                                         | Legacy chip |     | 1     | 3    | mV   |
|                    |                                |                                                                                 | New chip    |     | 1     | 2.75 |      |
|                    |                                | $I_{OUT} = 0\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$      | Legacy chip |     |       | 5    |      |
|                    |                                |                                                                                 | New chip    |     |       | 3    |      |
|                    |                                | $I_{OUT} = 1\text{ mA}$                                                         | Legacy chip |     | 7     | 10   |      |
|                    |                                |                                                                                 | New chip    |     | 11.5  | 14   |      |
|                    |                                | $I_{OUT} = 1\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$      | Legacy chip |     |       | 15   |      |
|                    |                                |                                                                                 | New chip    |     |       | 17   |      |
|                    |                                | $I_{OUT} = 10\text{ mA}$                                                        | Legacy chip |     | 40    | 60   |      |
|                    |                                |                                                                                 | New chip    |     | 98    | 115  |      |
|                    |                                | $I_{OUT} = 10\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$     | Legacy chip |     |       | 90   |      |
|                    |                                |                                                                                 | New chip    |     |       | 148  |      |
|                    |                                | $I_{OUT} = 50\text{ mA}$                                                        | Legacy chip |     | 120   | 150  |      |
|                    |                                |                                                                                 | New chip    |     | 120   | 145  |      |
|                    |                                | $I_{OUT} = 50\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$     | Legacy chip |     |       | 225  |      |
|                    |                                |                                                                                 | New chip    |     |       | 184  |      |
| $I_{GND}$          | GND pin current                | $I_{OUT} = 0\text{ mA}$                                                         | Legacy chip |     | 65    | 95   | uA   |
|                    |                                |                                                                                 | New chip    |     | 69    | 95   |      |
|                    |                                | $I_{OUT} = 0\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$      | Legacy chip |     | 65    | 125  |      |
|                    |                                |                                                                                 | New chip    |     |       | 120  |      |
|                    |                                | $I_{OUT} = 1\text{ mA}$                                                         | Legacy chip |     | 75    | 110  |      |
|                    |                                |                                                                                 | New chip    |     | 78    | 110  |      |
|                    |                                | $I_{OUT} = 1\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$      | Legacy chip |     |       | 170  |      |
|                    |                                |                                                                                 | New chip    |     |       | 140  |      |
|                    |                                | $I_{OUT} = 10\text{ mA}$                                                        | Legacy chip |     | 120   | 220  |      |
|                    |                                |                                                                                 | New chip    |     | 175   | 210  |      |
|                    |                                | $I_{OUT} = 10\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$     | Legacy chip |     |       | 400  |      |
|                    |                                |                                                                                 | New chip    |     |       | 250  |      |
|                    |                                | $I_{OUT} = 50\text{ mA}$                                                        | Legacy chip |     | 350   | 600  |      |
|                    |                                |                                                                                 | New chip    |     | 380   | 440  |      |
|                    |                                | $I_{OUT} = 50\text{ mA}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$     | Legacy chip |     |       | 900  |      |
|                    |                                |                                                                                 | New chip    |     |       | 650  |      |
|                    |                                | $V_{ON/OFF} < 0.18\text{ V}, -40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$ | Legacy chip |     | 0     | 1    |      |
|                    |                                |                                                                                 | New chip    |     | 1.12  | 2.25 |      |
| $V_{UVLO+}$        | Rising bias supply UVLO        | $V_{IN}$ rising, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$            | New chip    |     | 2.2   | 2.4  | V    |
| $V_{UVLO-}$        | Falling bias supply UVLO       | $V_{IN}$ falling, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$           |             |     | 1.9   | 2.07 |      |
| $V_{UVLO(HYST)}$   | UVLO hysteresis                | $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$                             |             |     | 0.130 |      |      |
| $I_{O(SC)}$        | Short output current           | $R_L = 0\text{ }\Omega$ (steady state)                                          | Legacy chip |     | 150   |      | mA   |
|                    |                                |                                                                                 | New chip    |     | 150   |      |      |
| $I_{O(PK)}$        | Peak output current            | $V_{OUT} \geq V_{O(NOM)} - 5\%$ (steady state)                                  | Legacy chip |     | 110   | 150  |      |
|                    |                                |                                                                                 | New chip    |     | 110   | 150  |      |

## 5.5 Electrical Characteristics (continued)

specified at  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(nom)} + 1.0\text{ V}$  or  $V_{IN} = 2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ ,  $V_{ON/OFF} = 2\text{ V}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ , and  $C_{OUT} = 2.2\text{ }\mu\text{F}$  (unless otherwise noted)

| PARAMETER                         |                            | TEST CONDITIONS                                                                                           |             | MIN  | TYP   | MAX | UNIT |
|-----------------------------------|----------------------------|-----------------------------------------------------------------------------------------------------------|-------------|------|-------|-----|------|
| V <sub>ON/OFF</sub>               | ON/OFF input voltage       | Low = Output OFF, V <sub>OUT</sub> + 1 ≤ V <sub>IN</sub> ≤ 16 V, −40°C ≤ T <sub>J</sub> ≤ 125°C           | Legacy chip | 0.55 | 0.18  | V   |      |
|                                   |                            |                                                                                                           | New chip    | 0.15 |       |     |      |
|                                   |                            | High = Output ON, V <sub>OUT</sub> + 1 ≤ V <sub>IN</sub> ≤ 16 V, −40°C ≤ T <sub>J</sub> ≤ 125°C           | Legacy chip | 1.6  | 1.4   |     |      |
|                                   |                            |                                                                                                           | New chip    | 1.6  |       |     |      |
| I <sub>ON/OFF</sub>               | ON/OFF input current       | V <sub>ON/OFF</sub> = 0 V, V <sub>OUT</sub> + 1 ≤ V <sub>IN</sub> ≤ 16 V, −40°C ≤ T <sub>J</sub> ≤ 125°C  | Legacy chip | 0    | -1    | uA  |      |
|                                   |                            |                                                                                                           | New chip    | -0.9 |       |     |      |
|                                   |                            | V <sub>ON/OFF</sub> = 5 V, V <sub>OUT</sub> + 1 ≤ V <sub>IN</sub> ≤ 16 V, −40°C ≤ T <sub>J</sub> ≤ 125°C  | Legacy chip | 5    | 15    |     |      |
|                                   |                            |                                                                                                           | New chip    | 2.20 |       |     |      |
| ΔV <sub>O</sub> /ΔV <sub>IN</sub> | Ripple rejection           | f = 1 kHz, C <sub>OUT</sub> = 10 μF                                                                       | Legacy chip | 63   | dB    |     |      |
|                                   |                            | f = 1 kHz, C <sub>OUT</sub> = 10 μF                                                                       | New chip    | 75   |       |     |      |
|                                   |                            | f = 100 kHz, I <sub>LOAD</sub> = 50mA                                                                     | New chip    | 45   |       |     |      |
| V <sub>n</sub>                    | Output noise voltage       | Bandwidth = 300 Hz to 50 kHz, C <sub>OUT</sub> = 10uF, V <sub>OUT</sub> = 3.3V, I <sub>LOAD</sub> = 50mA  | Legacy chip | 160  | μVRMS |     |      |
|                                   |                            | Bandwidth = 300 Hz to 50 kHz, C <sub>OUT</sub> = 2.2uF, V <sub>OUT</sub> = 3.3V, I <sub>LOAD</sub> = 50mA | New chip    | 140  |       |     |      |
|                                   |                            | Bandwidth = 10 Hz to 100 kHz, C <sub>OUT</sub> = 2.2uF, V <sub>OUT</sub> = 3.3V, I <sub>LOAD</sub> = 50mA | New chip    | 50   |       |     |      |
| T <sub>sd+</sub>                  | Thermal shutdown threshold | Shutdown, temperature increasing                                                                          | New chip    | 170  | °C    |     |      |
| T <sub>sd-</sub>                  |                            | Reset, temperature decreasing                                                                             |             | 150  |       |     |      |

- (1) Dropout voltage ( $V_{DO}$ ) is defined as the input-to-output differential at which the output voltage drops 100 mV below the value measured with a 1-V differential.  $V_{DO}$  is measured with  $V_{IN} = V_{OUT(nom)} - 100\text{ mV}$  for fixed output devices.

## 5.6 Typical Characteristics

at operating temperature  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0\text{ V}$  or  $2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ , ON/OFF pin tied to  $V_{IN}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ ,  $C_{OUT} = 2.2\text{ }\mu\text{F}$  for the legacy chip, and  $C_{OUT} = 4.7\text{ }\mu\text{F}$  for the new chip (unless otherwise noted)

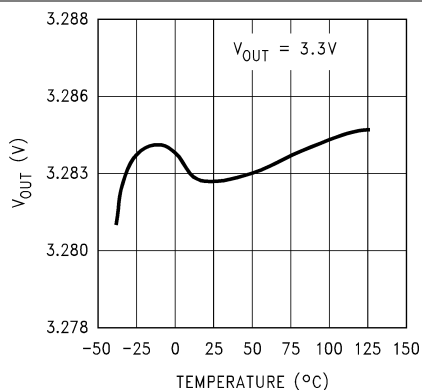


Figure 5-1. Output Voltage vs Temperature (Legacy Chip)

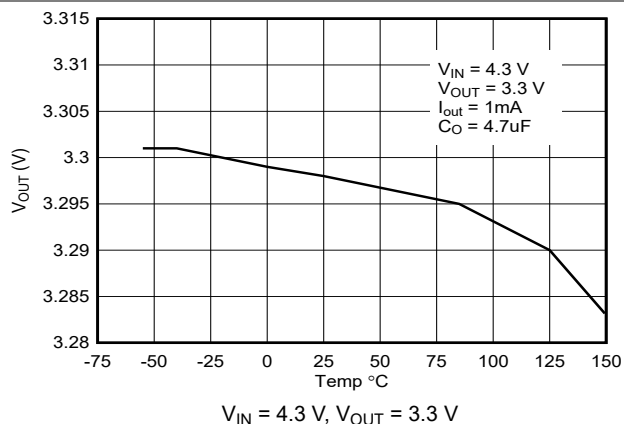


Figure 5-2. Output Voltage vs Temperature (New Chip)

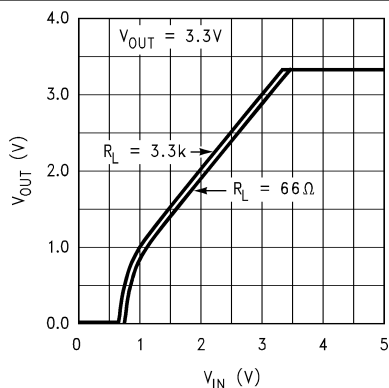


Figure 5-3. Output Voltage vs  $V_{IN}$  (Legacy Chip)

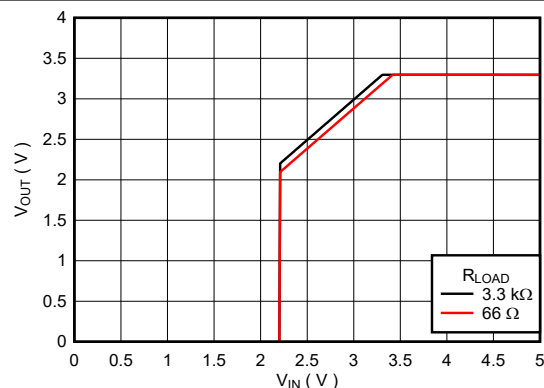


Figure 5-4. Output Voltage vs  $V_{IN}$  (New Chip)

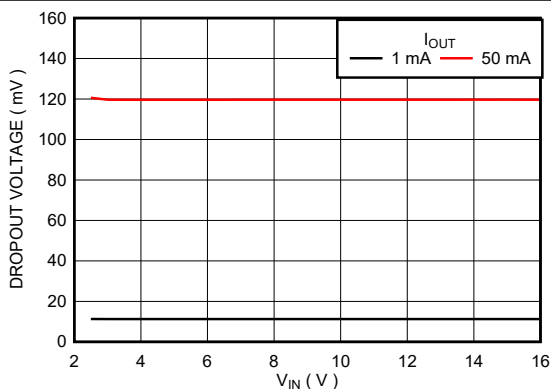


Figure 5-5. Dropout Voltage vs  $V_{IN}$  (New Chip)

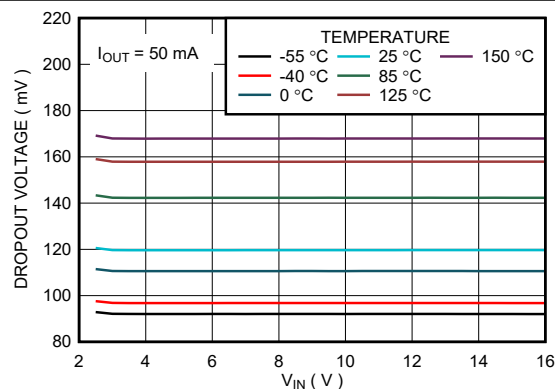


Figure 5-6. Dropout Voltage vs  $V_{IN}$  and Temperature (New Chip)

## 5.6 Typical Characteristics (continued)

at operating temperature  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0\text{ V}$  or  $2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ ,  $\text{ON}/\overline{\text{OFF}}$  pin tied to  $V_{IN}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ ,  $C_{OUT} = 2.2\text{ }\mu\text{F}$  for the legacy chip, and  $C_{OUT} = 4.7\text{ }\mu\text{F}$  for the new chip (unless otherwise noted)

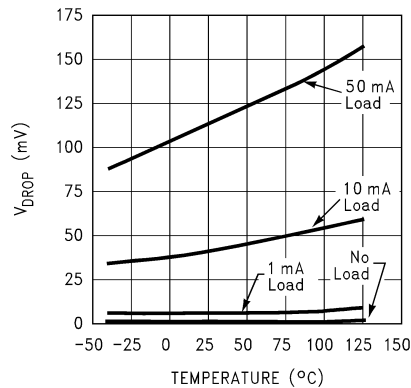


Figure 5-7. Dropout Voltage vs Temperature (Legacy Chip)

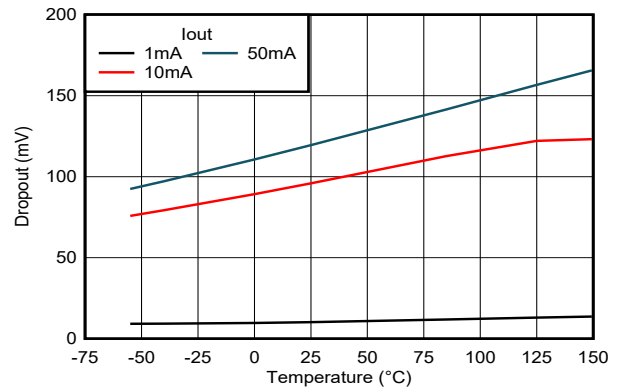


Figure 5-8. Dropout Voltage vs Temperature (New Chip)

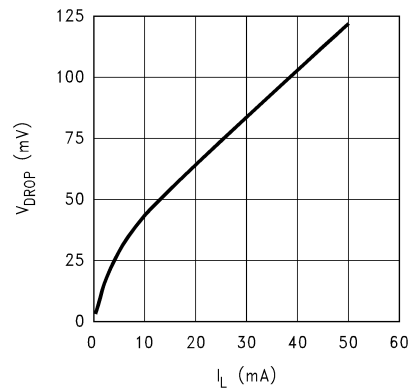


Figure 5-9. Dropout Voltage vs Load Current (Legacy Chip)

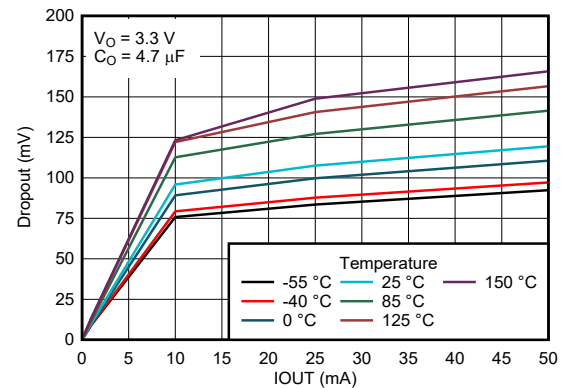


Figure 5-10. Dropout Voltage vs Load Current (New Chip)

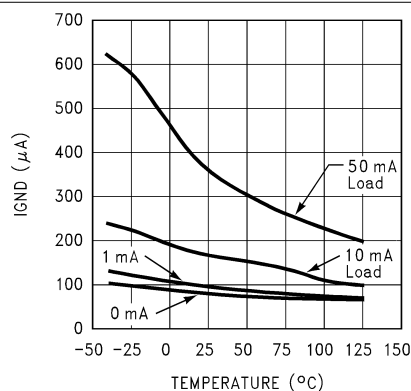


Figure 5-11. Ground Pin Current vs Temperature (Legacy Chip)

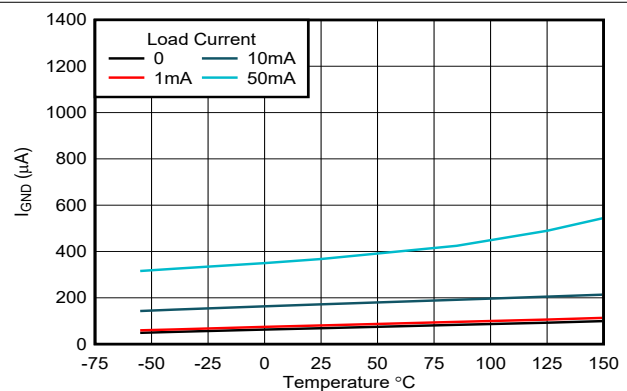


Figure 5-12. Ground Pin Current vs Temperature (New Chip)

## 5.6 Typical Characteristics (continued)

at operating temperature  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0\text{ V}$  or  $2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ , ON/OFF pin tied to  $V_{IN}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ ,  $C_{OUT} = 2.2\text{ }\mu\text{F}$  for the legacy chip, and  $C_{OUT} = 4.7\text{ }\mu\text{F}$  for the new chip (unless otherwise noted)

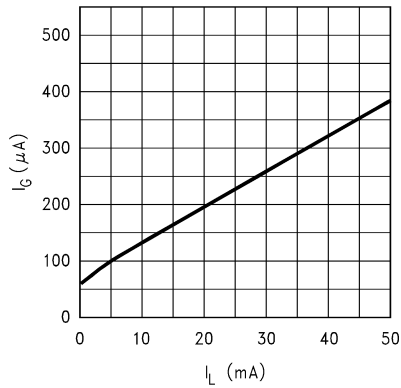


Figure 5-13. Ground Pin Current vs Load Current (Legacy Chip)

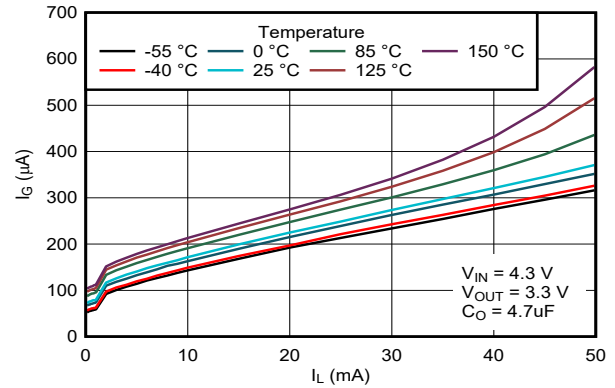


Figure 5-14. Ground Pin Current vs Load Current (New Chip)

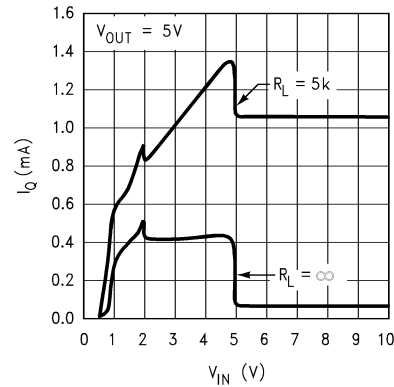


Figure 5-15. Input Current vs  $V_{IN}$  (Legacy Chip)

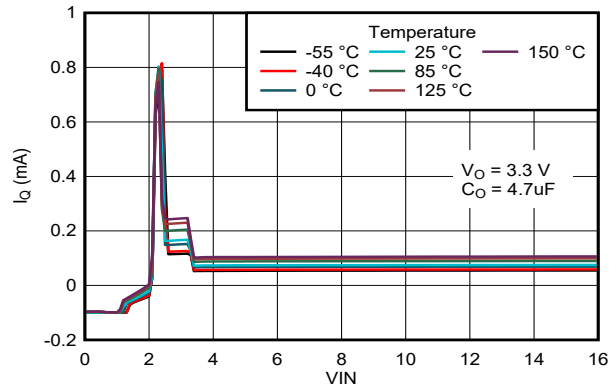


Figure 5-16. Input Current vs Input Voltage (New Chip)

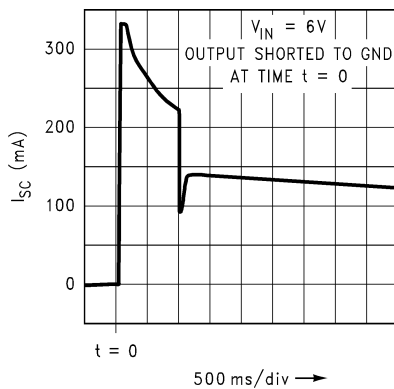


Figure 5-17. Short-Circuit Current vs Time (Legacy Chip)

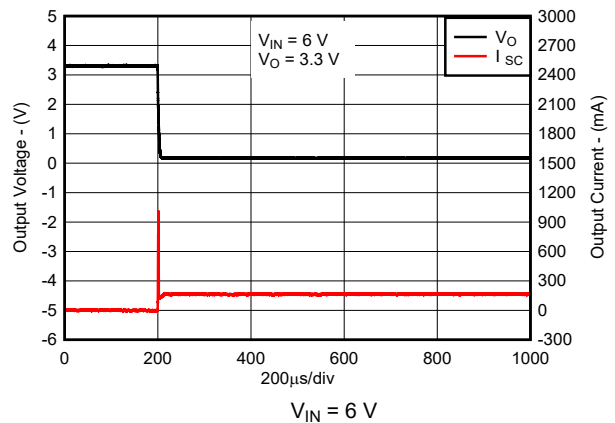


Figure 5-18. Short-Circuit Current vs Time (New Chip)

## 5.6 Typical Characteristics (continued)

at operating temperature  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0\text{ V}$  or  $2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ ,  $\text{ON}/\overline{\text{OFF}}$  pin tied to  $V_{IN}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ ,  $C_{OUT} = 2.2\text{ }\mu\text{F}$  for the legacy chip, and  $C_{OUT} = 4.7\text{ }\mu\text{F}$  for the new chip (unless otherwise noted)

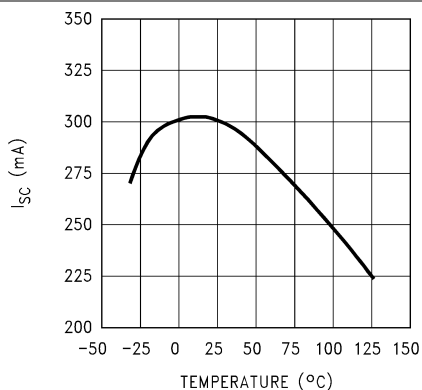


Figure 5-19. Short-Circuit Current vs Temperature (Legacy Chip)

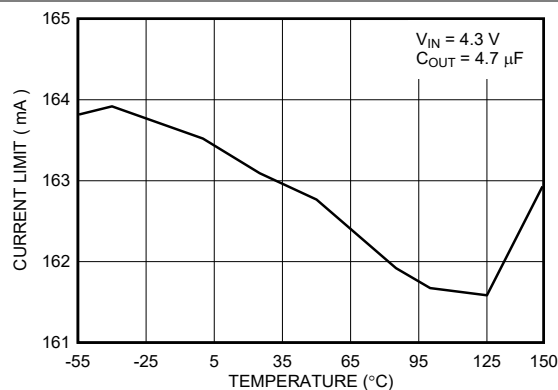


Figure 5-20. Short-Circuit Current vs Temperature (New Chip)

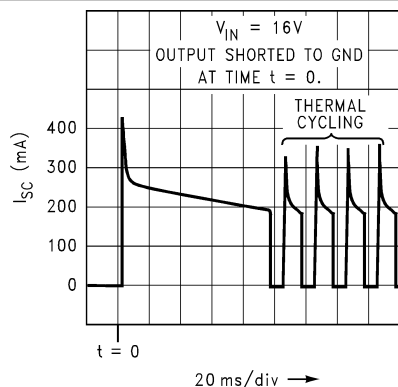


Figure 5-21. Short-Circuit Current vs Time (Legacy Chip)

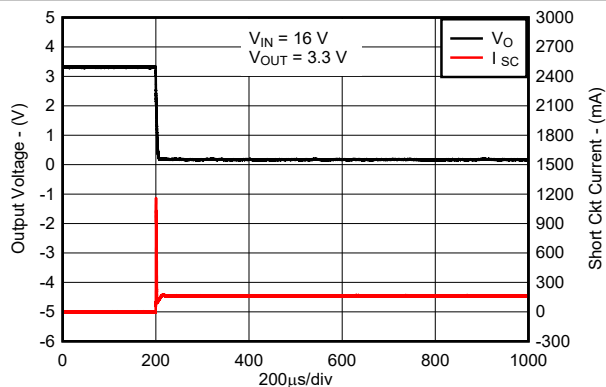


Figure 5-22. Short-Circuit Current vs Time (New Chip)

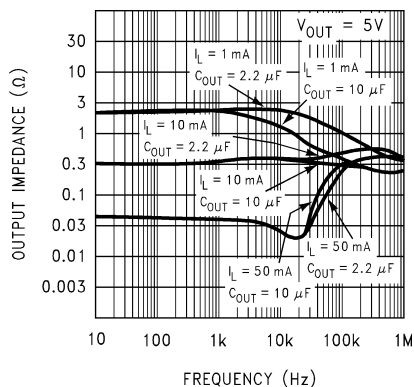


Figure 5-23. Output Impedance vs Frequency (Legacy Chip)

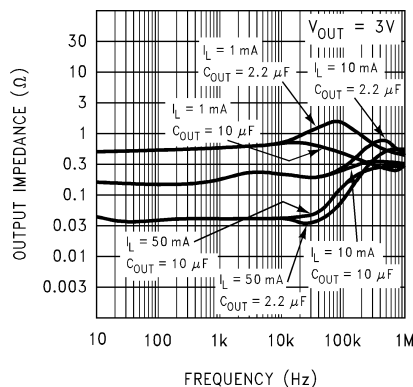


Figure 5-24. Output Impedance vs Frequency (Legacy Chip)

## 5.6 Typical Characteristics (continued)

at operating temperature  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0\text{ V}$  or  $2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ ,  $\text{ON}/\overline{\text{OFF}}$  pin tied to  $V_{IN}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ ,  $C_{OUT} = 2.2\text{ }\mu\text{F}$  for the legacy chip, and  $C_{OUT} = 4.7\text{ }\mu\text{F}$  for the new chip (unless otherwise noted)

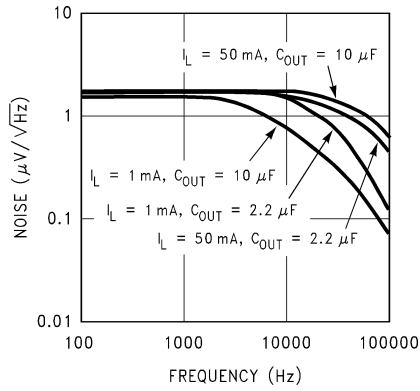


Figure 5-25. Output Noise Density (Legacy Chip)

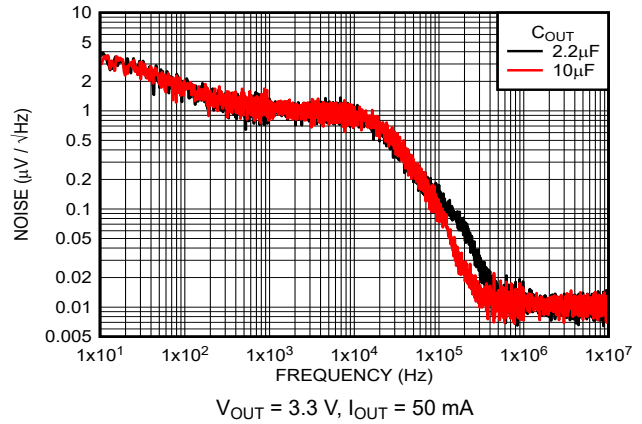


Figure 5-26. Output Noise Density vs  $C_{OUT}$  (New Chip)

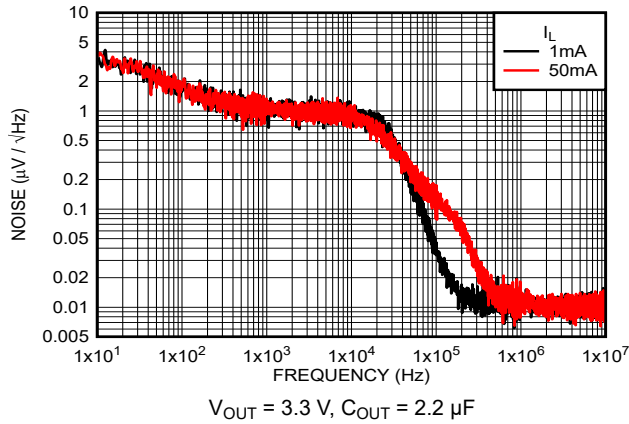


Figure 5-27. Output Noise Density vs  $I_{OUT}$  (New Chip)

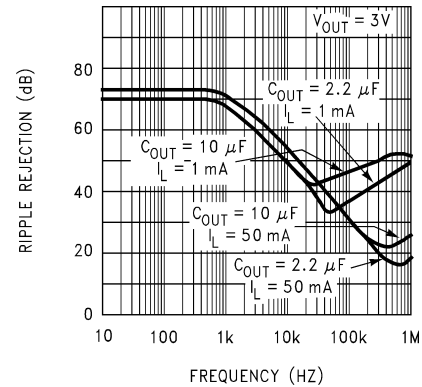


Figure 5-28. Ripple Rejection (Legacy Chip)

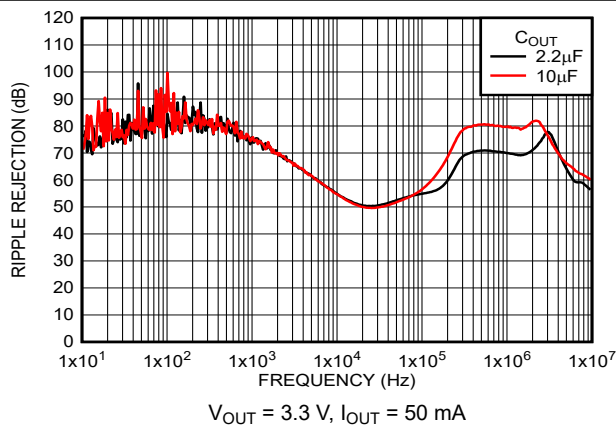


Figure 5-29. Ripple Rejection vs  $C_{OUT}$  (New Chip)

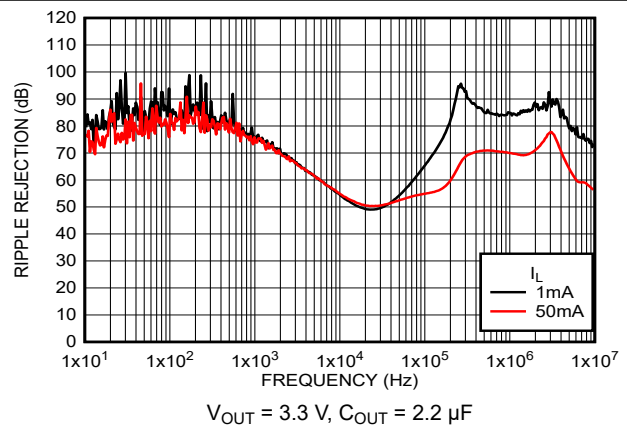
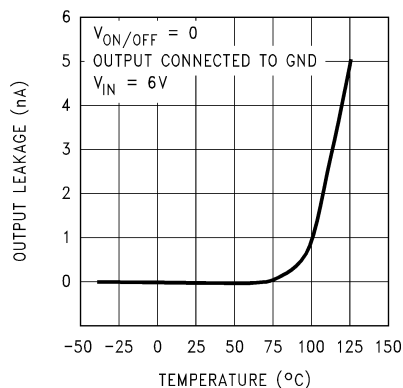


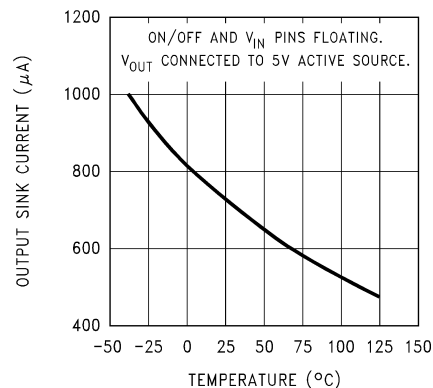
Figure 5-30. Ripple Rejection vs  $I_{OUT}$  (New Chip)

## 5.6 Typical Characteristics (continued)

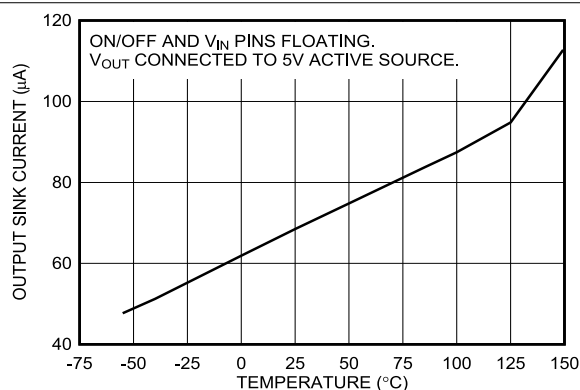
at operating temperature  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0\text{ V}$  or  $2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ ,  $ON/\overline{OFF}$  pin tied to  $V_{IN}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ ,  $C_{OUT} = 2.2\text{ }\mu\text{F}$  for the legacy chip, and  $C_{OUT} = 4.7\text{ }\mu\text{F}$  for the new chip (unless otherwise noted)



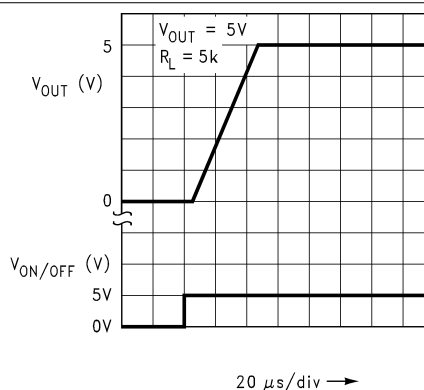
**Figure 5-31. Input to Output Leakage vs Temperature (Legacy Chip)**



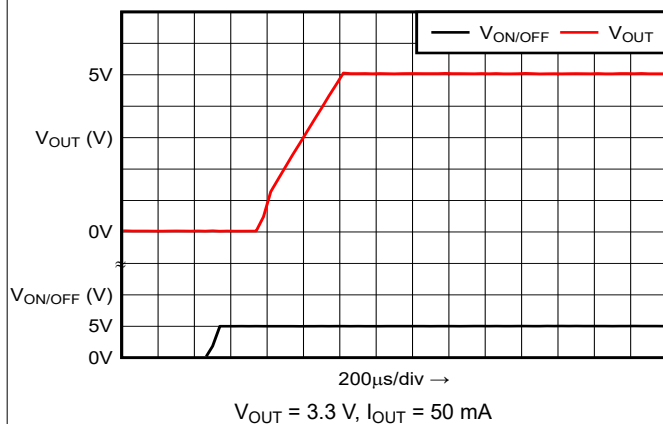
**Figure 5-32. Output Reverse Leakage vs Temperature (Legacy Chip)**



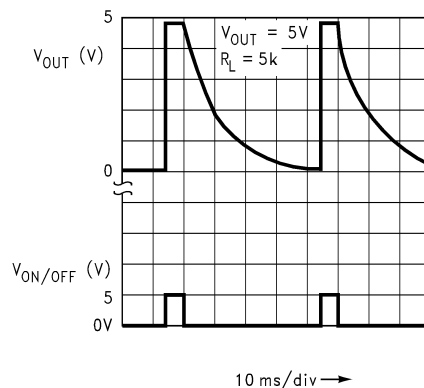
**Figure 5-33. Output Reverse Leakage vs Temperature (New Chip)**



**Figure 5-34. Turn-On Waveform (Legacy Chip)**



**Figure 5-35. Turn-On Waveform (New Chip)**



**Figure 5-36. Turnoff Waveform (Legacy Chip)**

## 5.6 Typical Characteristics (continued)

at operating temperature  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(\text{NOM})} + 1.0\text{ V}$  or  $2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ ,  $\text{ON}/\overline{\text{OFF}}$  pin tied to  $V_{IN}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ ,  $C_{OUT} = 2.2\text{ }\mu\text{F}$  for the legacy chip, and  $C_{OUT} = 4.7\text{ }\mu\text{F}$  for the new chip (unless otherwise noted)

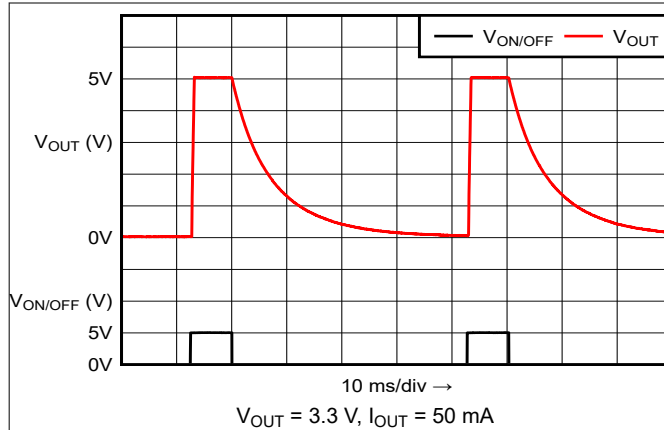


Figure 5-37. Turnoff Waveform (New Chip)

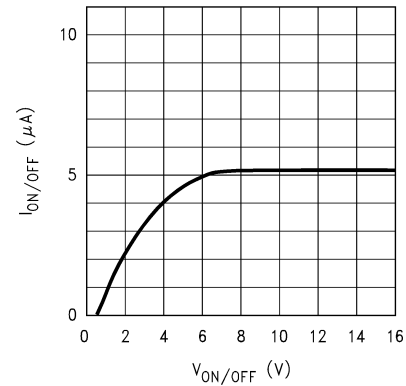


Figure 5-38.  $\text{ON}/\overline{\text{OFF}}$  Pin Current vs  $V_{\text{ON}/\overline{\text{OFF}}}$  (Legacy Chip)

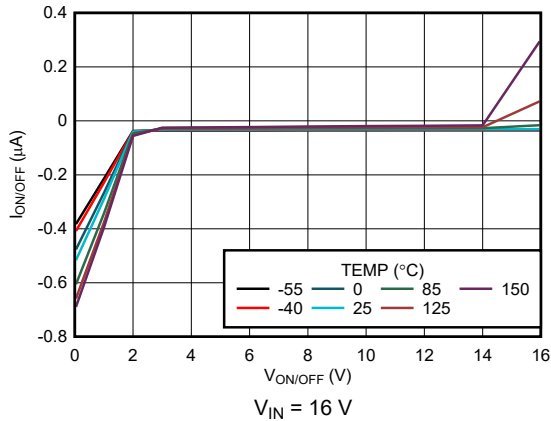


Figure 5-39.  $\text{ON}/\overline{\text{OFF}}$  Pin Current vs  $V_{\text{ON}/\overline{\text{OFF}}}$  (New Chip)

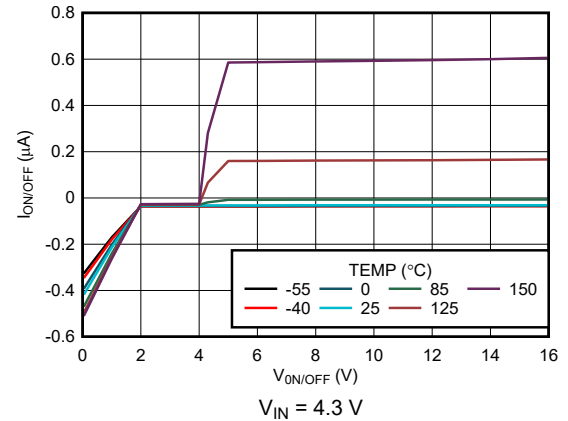


Figure 5-40.  $\text{ON}/\overline{\text{OFF}}$  Pin Current vs  $V_{\text{ON}/\overline{\text{OFF}}}$  (New Chip)

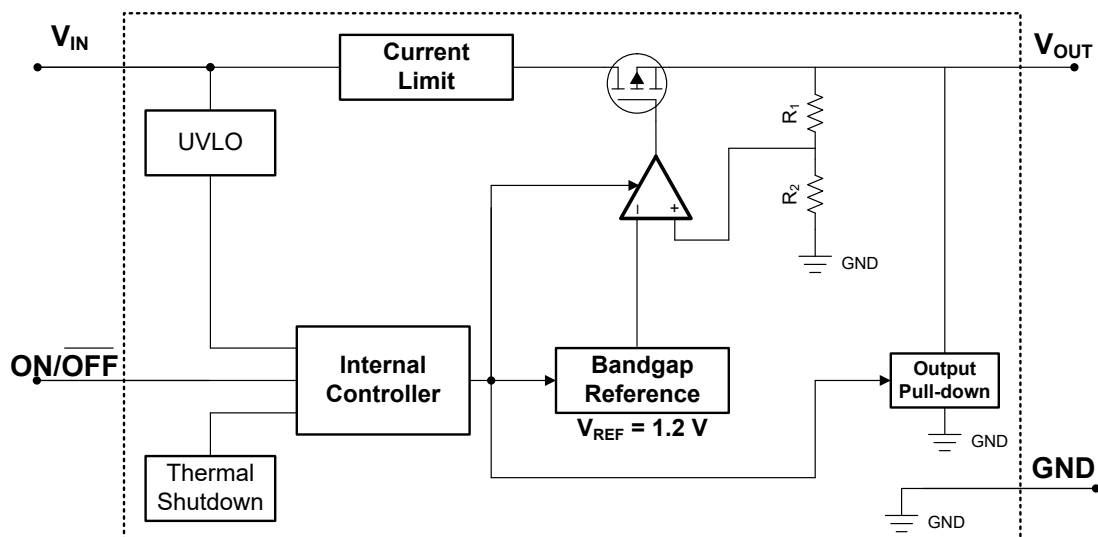
## 6 Detailed Description

### 6.1 Overview

The LP2980-N is a fixed-output, low-noise, high PSRR, low-dropout regulator that offers exceptional, cost-effective performance for both portable and nonportable applications. The LP2980-N has an output tolerance of 1% across line, load, and temperature variation (for the new chip) and is capable of delivering 50 mA of continuous load current.

This device features integrated overcurrent protection, thermal shutdown, output enable, and internal output pulldown and has a built-in soft-start mechanism for controlled inrush current. This device delivers excellent line and load transient performance. The operating ambient temperature range of the device is  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ .

### 6.2 Functional Block Diagram



### 6.3 Feature Description

#### 6.3.1 Output Enable

The ON/ $\overline{\text{OFF}}$  pin for the device is an active-high pin. The output voltage is enabled when the voltage of the ON/ $\overline{\text{OFF}}$  pin is greater than the high-level input voltage of the ON/ $\overline{\text{OFF}}$  pin and disabled when the ON/ $\overline{\text{OFF}}$  pin voltage is less than the low-level input voltage of the ON/ $\overline{\text{OFF}}$  pin. If independent control of the output voltage is not needed, connect the ON/ $\overline{\text{OFF}}$  pin to the input of the device.

For the new chip, the device has an internal pulldown circuit that activates when the device is disabled by pulling the ON/ $\overline{\text{OFF}}$  pin voltage lower than the low-level input voltage of the ON/ $\overline{\text{OFF}}$  pin to actively discharge the output voltage.

#### 6.3.2 Dropout Voltage

Dropout voltage ( $V_{\text{DO}}$ ) is defined as the input voltage minus the output voltage ( $V_{\text{IN}} - V_{\text{OUT}}$ ) at the rated output current ( $I_{\text{RATED}}$ ), where the pass transistor is fully on.  $I_{\text{RATED}}$  is the maximum  $I_{\text{OUT}}$  listed in the *Recommended Operating Conditions* table. The pass transistor is in the ohmic or triode region of operation, and acts as a switch. The dropout voltage indirectly specifies a minimum input voltage greater than the nominal programmed output voltage at which the output voltage is expected to stay in regulation. If the input voltage falls to less than the nominal output regulation, then the output voltage falls as well.

For a CMOS regulator, the dropout voltage is determined by the drain-source on-state resistance ( $R_{\text{DS(ON)}}$ ) of the pass transistor. Therefore, if the linear regulator operates at less than the rated current, the dropout voltage for that current scales accordingly. The following equation calculates the  $R_{\text{DS(ON)}}$  of the device.

$$R_{\text{DS(ON)}} = \frac{V_{\text{DO}}}{I_{\text{RATED}}} \quad (1)$$

### 6.3.3 Current Limit

The device has an internal current limit circuit that protects the regulator during transient high-load current faults or shorting events. The current limit is a brick-wall scheme. In a high-load current fault, the brick-wall scheme limits the output current to the current limit ( $I_{CL}$ ).  $I_{CL}$  is listed in the *Electrical Characteristics* table.

The output voltage is not regulated when the device is in current limit. When a current limit event occurs, the device begins to heat up because of the increase in power dissipation. When the device is in brick-wall current limit, the pass transistor dissipates power  $[(V_{IN} - V_{OUT}) \times I_{CL}]$ . If thermal shutdown is triggered, the device turns off. After the device cools down, the internal thermal shutdown circuit turns the device back on. If the output current fault condition continues, the device cycles between current limit and thermal shutdown. For more information on current limits, see the [Know Your Limits application note](#).

Figure 6-1 shows a diagram of the current limit.

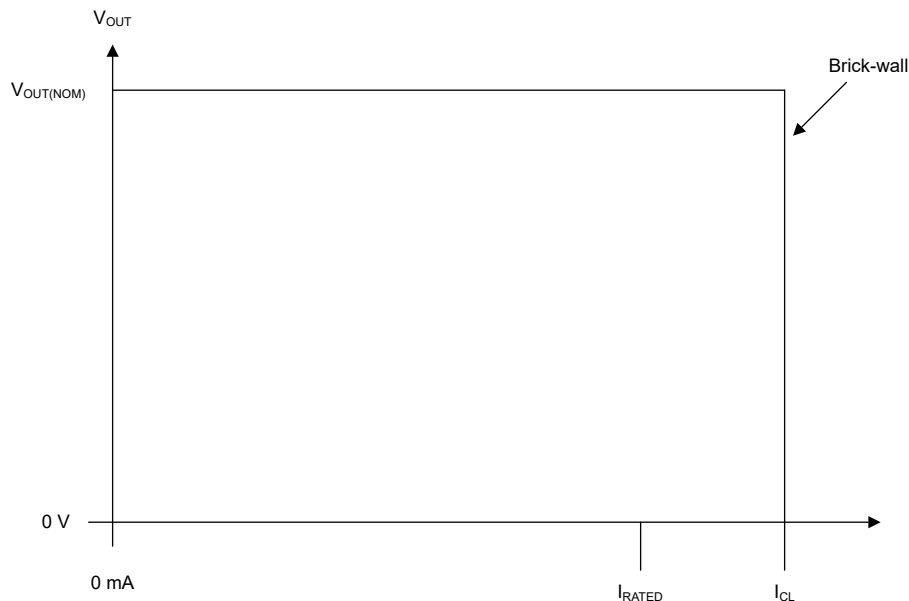


Figure 6-1. Current Limit

### 6.3.4 Undervoltage Lockout (UVLO)

For the new chip, the device has an independent undervoltage lockout (UVLO) circuit that monitors the input voltage, allowing a controlled and consistent turn on and off of the output voltage. To prevent the device from turning off if the input drops during turn on, the UVLO has hysteresis as specified in the *Electrical Characteristics* table.

### 6.3.5 Output Pulldown

The new chip has an output pulldown circuit. The output pulldown activates in the following conditions:

- When the device is disabled ( $V_{ON/OFF} < V_{ON/OFF(LOW)}$ )
- If  $1.0\text{ V} < V_{IN} < V_{UVLO}$

Do not rely on the output pulldown circuit for discharging a large amount of output capacitance after the input supply has collapsed because reverse current can flow from the output to the input. This reverse current flow can cause damage to the device. See the [Reverse Current](#) section for more details.

### 6.3.6 Thermal Shutdown

The device contains a thermal shutdown protection circuit to disable the device when the junction temperature ( $T_J$ ) of the pass transistor rises to  $T_{SD(shutdown)}$  (typical). Thermal shutdown hysteresis makes sure that the device resets (turns on) when the temperature falls to  $T_{SD(reset)}$  (typical).

The thermal time-constant of the semiconductor die is fairly short, thus the device can cycle on and off when thermal shutdown is reached until power dissipation is reduced. Power dissipation during start up can be high from large  $V_{IN} - V_{OUT}$  voltage drops across the device or from high inrush currents charging large output capacitors. Under some conditions, the thermal shutdown protection disables the device before start-up completes.

For reliable operation, limit the junction temperature to the maximum listed in the *Recommended Operating Conditions* table. Operation above this maximum temperature causes the device to exceed operational specifications. Although the internal protection circuitry of the device is designed to protect against thermal overall conditions, this circuitry is not intended to replace proper heat sinking. Continuously running the device into thermal shutdown or above the maximum recommended junction temperature reduces long-term reliability.

## 6.4 Device Functional Modes

### 6.4.1 Normal Operation

The device regulates to the nominal output voltage when the following conditions are met:

- The input voltage is greater than the nominal output voltage plus the dropout voltage ( $V_{OUT(NOM)} + V_{DO}$ )
- The output current is less than the current limit ( $I_{OUT} < I_{CL}$ )
- The device junction temperature is less than the thermal shutdown temperature ( $T_J < T_{SD}$ )
- The ON/OFF voltage has previously exceeded the ON/OFF rising threshold voltage and has not yet decreased to less than the enable falling threshold

### 6.4.2 Dropout Operation

If the input voltage is lower than the nominal output voltage plus the specified dropout voltage, but all other conditions are met for normal operation, the device operates in dropout mode. In this mode, the output voltage tracks the input voltage. During this mode, the transient performance of the device becomes significantly degraded because the pass transistor is in the ohmic or triode region, and acts as a switch. Line or load transients in dropout can result in large output-voltage deviations.

When the device is in a steady dropout state (defined as when the device is in dropout,  $V_{IN} < V_{OUT(NOM)} + V_{DO}$ , directly after being in a normal regulation state, but *not* during start up), the pass transistor is driven into the ohmic or triode region. When the input voltage returns to a value greater than or equal to the nominal output voltage plus the dropout voltage ( $V_{OUT(NOM)} + V_{DO}$ ), the output voltage can overshoot for a short period of time while the device pulls the pass transistor back into the linear region.

### 6.4.3 Disabled

The output of the device can be shutdown by forcing the voltage of the ON/OFF pin to less than the maximum ON/OFF pin low-level input voltage (see the *Electrical Characteristics* table). When disabled, the pass transistor is turned off, internal circuits are shutdown, and the output voltage is actively discharged to ground by an internal discharge circuit from the output to ground.

## 7 Application and Implementation

### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 7.1 Application Information

#### 7.1.1 Recommended Capacitor Types

This section describes the recommended capacitors for both the new chip and the legacy chip.

##### 7.1.1.1 Recommended Capacitors for the Legacy Chip

The ESR of a good-quality tantalum capacitor is almost directly centered in the middle of the *stable* range of the ESR curve (approximately  $0.5\ \Omega$ – $1\ \Omega$ ). The temperature stability of tantalum capacitors is typically very good, with a total variation of only approximately 2:1 over the temperature range of  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  (ESR increases at colder temperatures). Avoid off-brand capacitors because some poor-quality tantalum capacitors are available with ESR values greater than  $10\ \Omega$ , which usually causes oscillation problems. One caution regarding tantalum capacitors is that if used on the input, the ESR is low enough to be destroyed by a surge current if the capacitor is powered up from a low impedance source (such as a battery) that has no limit on inrush current. In this case, use a ceramic input capacitor that does not have this problem.

Ceramic capacitors are generally larger and more costly than tantalum capacitors for a given amount of capacitance. These capacitors also have a very low ESR that is quite stable with temperature. However, the ESR of a ceramic capacitor is typically low enough to make an LDO oscillate. A  $2.2\text{-}\mu\text{F}$  ceramic capacitor demonstrated an ESR of approximately  $15\ \text{m}\Omega$  when tested. If used as an output capacitor, this ESR can cause instability (see the ESR curves in the [Typical Characteristics](#) section). If a ceramic capacitor is used on the output of an LDO, place a small resistor (approximately  $1\ \Omega$ ) in series with the capacitor. If used as an input capacitor, no resistor is needed because there is no requirement for ESR on capacitors used on the input.

##### 7.1.1.2 Recommended Capacitors for the New Chip

The new chip is designed to be stable using low equivalent series resistance (ESR) ceramic capacitors at the input and output. Multilayer ceramic capacitors have become the industry standard for these types of applications and are recommended, but must be used with good judgment. Ceramic capacitors that employ X7R-, X5R-, and C0G-rated dielectric materials provide relatively good capacitive stability across temperature, whereas using Y5V-rated capacitors is discouraged because of large variations in capacitance.

Regardless of the ceramic capacitor type selected, the effective capacitance varies with operating voltage and temperature. Generally, expect the effective capacitance to decrease by as much as 50%. The input and output capacitors listed in the *Recommended Operating Conditions* table account for an effective capacitance of approximately 50% of the nominal value.

#### 7.1.2 Input and Output Capacitor Requirements

For the legacy chip, an input capacitor ( $C_{\text{IN}}$ )  $\geq 1\ \mu\text{F}$  is required (the amount of capacitance can be increased without limit). Any good-quality tantalum or ceramic capacitor can be used. The capacitor must be located no more than half an inch from the input pin and returned to a clean analog ground.

For the new chip, although an input capacitor is not required for stability, good analog design practice is to connect a capacitor from IN to GND. This capacitor counteracts reactive input sources and improves transient response, input ripple, and PSRR. Use an input capacitor if the source impedance is more than  $0.5\ \Omega$ . A higher value capacitor can be necessary if large, fast rise-time load or line transients are anticipated or if the device is located several inches from the input power source.

Dynamic performance of the device is improved with the use of an output capacitor. Use an output capacitor within the range specified in the *Recommended Operating Conditions* table for stability.

### 7.1.3 Estimating Junction Temperature

The JEDEC standard now recommends the use of psi ( $\Psi$ ) thermal metrics to estimate the junction temperatures of the linear regulator when in-circuit on a typical PCB board application. These metrics are not thermal resistance parameters and instead offer a practical and relative way to estimate junction temperature. These psi metrics are determined to be significantly independent of the copper area available for heat-spreading. The *Thermal Information* table lists the primary thermal metrics, which are the junction-to-top characterization parameter ( $\psi_{JT}$ ) and junction-to-board characterization parameter ( $\psi_{JB}$ ). These parameters provide two methods for calculating the junction temperature ( $T_J$ ), as described in the following equations. Use the junction-to-top characterization parameter ( $\psi_{JT}$ ) with the temperature at the center-top of device package ( $T_T$ ) to calculate the junction temperature. Use the junction-to-board characterization parameter ( $\psi_{JB}$ ) with the PCB surface temperature 1 mm from the device package ( $T_B$ ) to calculate the junction temperature.

$$T_J = T_T + \psi_{JT} \times P_D \quad (2)$$

where:

- $P_D$  is the dissipated power
- $T_T$  is the temperature at the center-top of the device package

$$T_J = T_B + \psi_{JB} \times P_D \quad (3)$$

where:

- $T_B$  is the PCB surface temperature measured 1 mm from the device package and centered on the package edge

For detailed information on the thermal metrics and how to use them, see the [Semiconductor and IC Package Thermal Metrics application note](#).

### 7.1.4 Power Dissipation ( $P_D$ )

Circuit reliability requires consideration of the device power dissipation, location of the circuit on the printed circuit board (PCB), and correct sizing of the thermal plane. The PCB area around the regulator must have few or no other heat-generating devices that cause added thermal stress.

To first-order approximation, power dissipation in the regulator depends on the input-to-output voltage difference and load conditions. The following equation calculates power dissipation ( $P_D$ ).

$$P_D = (V_{IN} - V_{OUT}) \times I_{OUT} \quad (4)$$

#### Note

Power dissipation can be minimized, and therefore greater efficiency can be achieved, by correct selection of the system voltage rails. For the lowest power dissipation use the minimum input voltage required for correct output regulation.

For devices with a thermal pad, the primary heat conduction path for the device package is through the thermal pad to the PCB. Solder the thermal pad to a copper pad area under the device. This pad area must contain an array of plated vias that conduct heat to additional copper planes for increased heat dissipation.

The maximum power dissipation determines the maximum allowable ambient temperature ( $T_A$ ) for the device. According to the following equation, power dissipation and junction temperature are most often related by the junction-to-ambient thermal resistance ( $R_{\theta JA}$ ) of the combined PCB and device package and the temperature of the ambient air ( $T_A$ ).

$$T_J = T_A + (R_{\theta JA} \times P_D) \quad (5)$$

Thermal resistance ( $R_{\theta JA}$ ) is highly dependent on the heat-spreading capability built into the particular PCB design, and therefore varies according to the total copper area, copper weight, and location of the planes. The junction-to-ambient thermal resistance listed in the *Thermal Information* table is determined by the JEDEC standard PCB and copper-spreading area, and is used as a relative measure of package thermal performance. As mentioned in the [An empirical analysis of the impact of board layout on LDO thermal performance application note](#),  $R_{\theta JA}$  can be improved by 35% to 55% compared to the *Thermal Information* table value with the PCB board layout optimization.

### 7.1.5 Reverse Current

Excessive reverse current can damage this device. Reverse current flows through the intrinsic body diode of the pass transistor instead of the normal conducting channel. At high magnitudes, this current flow degrades the long-term reliability of the device.

Conditions where reverse current can occur are outlined in this section, all of which can exceed the absolute maximum rating of  $V_{OUT} \leq V_{IN} + 0.3$  V.

- If the device has a large  $C_{OUT}$  and the input supply collapses with little or no load current
- The output is biased when the input supply is not established
- The output is biased above the input supply

If reverse current flow is expected in the application, use external protection to protect the device. Reverse current is not limited in the device, so external limiting is required if extended reverse voltage operation is anticipated.

Figure 7-1 shows one approach for protecting the device.

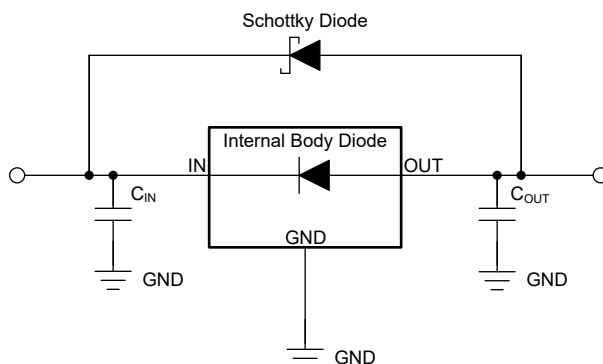
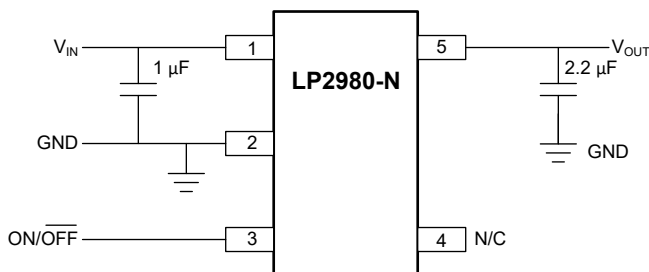


Figure 7-1. Example Circuit for Reverse Current Protection Using a Schottky Diode

## 7.2 Typical Application

Figure 7-2 shows the standard usage of the LP2980-N as a low-dropout regulator.



NOTE: Do not make connections to NC pin.

Figure 7-2. LP2980-N Typical Application

## 7.2.1 Design Requirements

For this design, use the minimum  $C_{OUT}$  value for stability (which can be increased without limit for improved stability and transient response). The ON/OFF pin must be actively terminated. Connect this pin to  $V_{IN}$  if the shutdown feature is not used.

For the new chip, [Table 7-1](#) summarizes the design requirements for [Figure 7-2](#).

**Table 7-1. Design Parameter**

| PARAMETER      | DESIGN REQUIREMENT |
|----------------|--------------------|
| Input voltage  | 12 V               |
| Output voltage | 3.3 V              |
| Output current | 50 mA              |

## 7.2.2 Detailed Design Procedure

### 7.2.2.1 ON/OFF Input Operation

The LP2980-N is shut off by driving the ON/OFF input low, and turned on by pulling the ON/OFF input high. If this feature is not used, the ON/OFF input must be tied to  $V_{IN}$  to keep the regulator output on at all times (the ON/OFF input must not be left floating).

To provide proper operation, the signal source used to drive the ON/OFF input must be able to swing above and below the specified turn-on and turn-off voltage thresholds that specify an ON or OFF state (see the *Electrical Characteristics* table).

For the legacy chip, the turn-on (and turn-off) voltage signals applied to the ON/OFF input must have a slew rate greater than 40 mV/ $\mu$ s.

For the new chip, there is no restriction on the slew rate of the voltage signals applied to the ON/OFF input. Both fast and slow ramping voltage signals can be used to drive the ON/OFF pin.

### Note

For the legacy chip only, the ON/OFF function does not operate correctly if a slow-moving signal is used to drive the ON/OFF input.

### 7.2.3 Application Curves

at operating temperature  $T_J = 25^\circ\text{C}$ ,  $V_{IN} = V_{OUT(NOM)} + 1.0\text{ V}$  or  $2.5\text{ V}$  (whichever is greater),  $I_{OUT} = 1\text{ mA}$ , ON/OFF pin tied to  $V_{IN}$ ,  $C_{IN} = 1.0\text{ }\mu\text{F}$ , and  $C_{OUT} = 4.7\text{ }\mu\text{F}$  (unless otherwise noted)

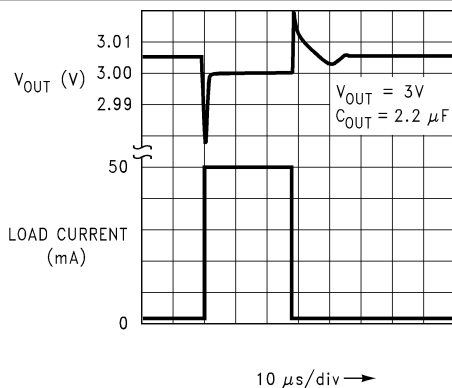


Figure 7-3. Load Transient Response (Legacy Chip)

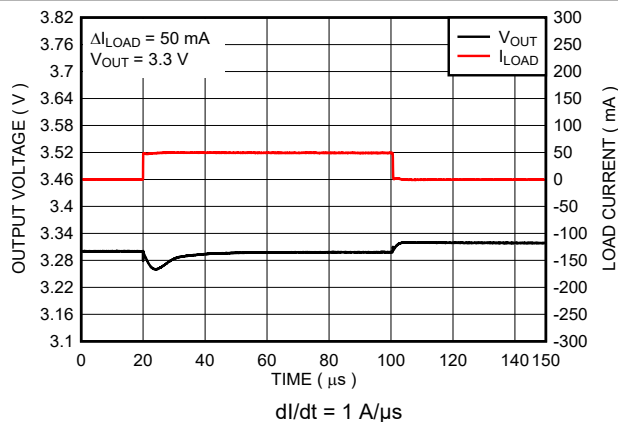


Figure 7-4. Load Transient Response (New Chip)

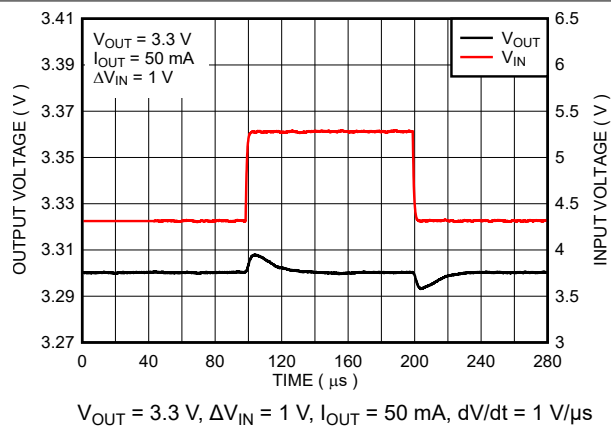


Figure 7-5. Line Transient Response (New Chip)

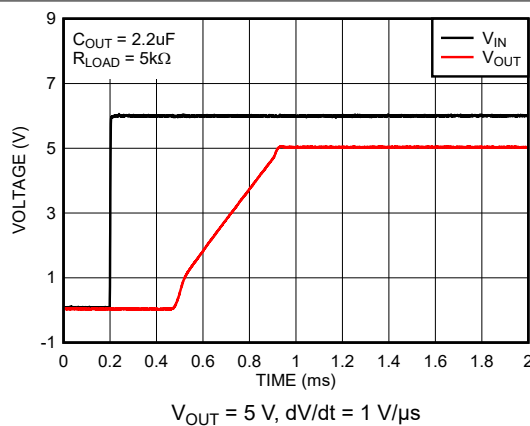


Figure 7-6. Start-Up (New Chip)

## 7.3 Power Supply Recommendations

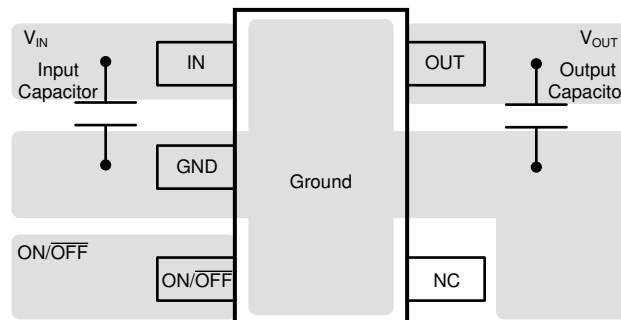
A power supply can be used at the input voltage within the ranges given in the *Recommended Operating Conditions* table.

## 7.4 Layout

### 7.4.1 Layout Guidelines

For best overall performance, place all circuit components on the same side of the circuit board and as near as practical to the respective LDO pin connections. Place ground return connections to the input and output capacitors, and to the LDO ground pin as close as possible to each other, connected by a wide, component-side, copper surface. Using vias and long traces to create LDO circuit connections is strongly discouraged and negatively affects system performance. This grounding and layout scheme minimizes inductive parasitics, and thereby reduces load-current transients, minimizes noise, and increases circuit stability. Use a ground reference plane that is either embedded in the PCB or located on the bottom side of the PCB opposite the components. This reference plane provides accuracy of the output voltage, shields noise, and behaves similar to a thermal plane to spread (or sink) heat from the LDO device. In most applications, this ground plane is necessary to meet thermal requirements.

### 7.4.2 Layout Example



**Figure 7-7. LP2980-N Layout Example**

## 8 Device and Documentation Support

### 8.1 Device Support

#### 8.1.1 Third-Party Products Disclaimer

TI'S PUBLICATION OF INFORMATION REGARDING THIRD-PARTY PRODUCTS OR SERVICES DOES NOT CONSTITUTE AN ENDORSEMENT REGARDING THE SUITABILITY OF SUCH PRODUCTS OR SERVICES OR A WARRANTY, REPRESENTATION OR ENDORSEMENT OF SUCH PRODUCTS OR SERVICES, EITHER ALONE OR IN COMBINATION WITH ANY TI PRODUCT OR SERVICE.

### 8.2 Device Nomenclature

**Table 8-1. Available Options<sup>(1)</sup>**

| PRODUCT                              | V <sub>OUT</sub>                                                                                                                                                                                                                                                                                                                                                          |
|--------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| LP2980cxxxzX-y.y/NOPB<br>Legacy chip | c is the accuracy specification. xxx is the package designator. z is the package quantity. X is for a large-quantity reel and non-X is for a small-quantity reel. y.y is the nominal output voltage (for example, 3.3 = 3.3 V; 5.0 = 5.0 V).                                                                                                                              |
| LP2980AxxxzX-y.y/M3<br>New chip      | A is for higher accuracy and non-A is for standard grade. xxx is the package designator. z is the package quantity. X is for a large-quantity reel and non-X is for a small-quantity reel. y.y is the nominal output voltage (for example, 3.3 = 3.3 V; 5.0 = 5.0 V). M3 is a suffix designator for newer chip redesigns, fabricated on the latest TI process technology. |

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder at [www.ti.com](http://www.ti.com).

### 8.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](http://ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 8.4 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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### 8.5 Trademarks

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### 8.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 8.7 Glossary

#### TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| <b>Changes from Revision P (August 2016) to Revision Q (November 2023)</b>                                                                                   | <b>Page</b> |
|--------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------|
| • Updated the numbering format for tables, figures, and cross-references throughout the document.....                                                        | 1           |
| • Changed entire document to align with current family format.....                                                                                           | 1           |
| • Added M3 devices to document.....                                                                                                                          | 1           |
| • Updated <i>Absolute Maximum Ratings, Recommended Operating Conditions, Electrical Characteristics and Thermal Information</i> for M3-suffix(new chip)..... | 4           |
| • Added <i>Device Nomenclature</i> section.....                                                                                                              | 24          |

| <b>Changes from Revision O (June 2015) to Revision P (August 2016)</b>                                          | <b>Page</b> |
|-----------------------------------------------------------------------------------------------------------------|-------------|
| • Changed minor wording in <i>Description</i> for clarity.....                                                  | 1           |
| • Changed "...an output tolerance of %..." to "...an initial output voltage tolerance of $\pm 0.5\%$ ..." ..... | 14          |
| • Deleted "Very high accuracy 1.23-V reference" .....                                                           | 14          |
| • Changed "150 mA" to "50 mA" to correct typo from reformat (2 places).....                                     | 14          |
| • Changed "...only 1 $\mu\text{A}$ " to "...less than 1 $\mu\text{A}$ ".....                                    | 14          |
| • Changed "... pulled low" to "...pulled to less than 0.18 V" .....                                             | 14          |

## 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

| Orderable Device     | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|----------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| LP2980AIM5-2.5/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L0NA                    | <a href="#">Samples</a> |
| LP2980AIM5-3.0/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L02A                    | <a href="#">Samples</a> |
| LP2980AIM5-3.3/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L00A                    | <a href="#">Samples</a> |
| LP2980AIM5-4.7/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 1000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L37A                    | <a href="#">Samples</a> |
| LP2980AIM5-5.0/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L01A                    | <a href="#">Samples</a> |
| LP2980AIM5X-2.5/NOPB | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L0NA                    | <a href="#">Samples</a> |
| LP2980AIM5X-3.0/NOPB | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L02A                    | <a href="#">Samples</a> |
| LP2980AIM5X-3.3/NOPB | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L00A                    | <a href="#">Samples</a> |
| LP2980AIM5X-4.7/NOPB | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L37A                    | <a href="#">Samples</a> |
| LP2980AIM5X-5.0/NOPB | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L01A                    | <a href="#">Samples</a> |
| LP2980IM5-2.5/NOPB   | ACTIVE        | SOT-23       | DBV                | 5    | 1000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L0NB                    | <a href="#">Samples</a> |
| LP2980IM5-3.0/NOPB   | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | NIPDAU   SN                          | Level-1-260C-UNLIM   | -40 to 125   | L02B                    | <a href="#">Samples</a> |
| LP2980IM5-3.3/NOPB   | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | NIPDAU   SN                          | Level-1-260C-UNLIM   | -40 to 125   | L00B                    | <a href="#">Samples</a> |
| LP2980IM5-3.8/NOPB   | ACTIVE        | SOT-23       | DBV                | 5    | 1000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L21B                    | <a href="#">Samples</a> |
| LP2980IM5-4.7/NOPB   | ACTIVE        | SOT-23       | DBV                | 5    | 1000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L37B                    | <a href="#">Samples</a> |
| LP2980IM5-5.0/NOPB   | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | NIPDAU   SN                          | Level-1-260C-UNLIM   | -40 to 125   | L01B                    | <a href="#">Samples</a> |
| LP2980IM5X-2.5/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | SN                                   | Level-1-260C-UNLIM   | -40 to 125   | L0NB                    | <a href="#">Samples</a> |
| LP2980IM5X-3.0/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | NIPDAU   SN                          | Level-1-260C-UNLIM   | -40 to 125   | L02B                    | <a href="#">Samples</a> |
| LP2980IM5X-3.3/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | NIPDAU   SN                          | Level-1-260C-UNLIM   | -40 to 125   | L00B                    | <a href="#">Samples</a> |
| LP2980IM5X-5.0/NOPB  | ACTIVE        | SOT-23       | DBV                | 5    | 3000           | RoHS & Green    | NIPDAU   SN                          | Level-1-260C-UNLIM   | -40 to 125   | L01B                    | <a href="#">Samples</a> |

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of  $\leq 1000$ ppm threshold. Antimony trioxide based flame retardants must also meet the  $\leq 1000$ ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

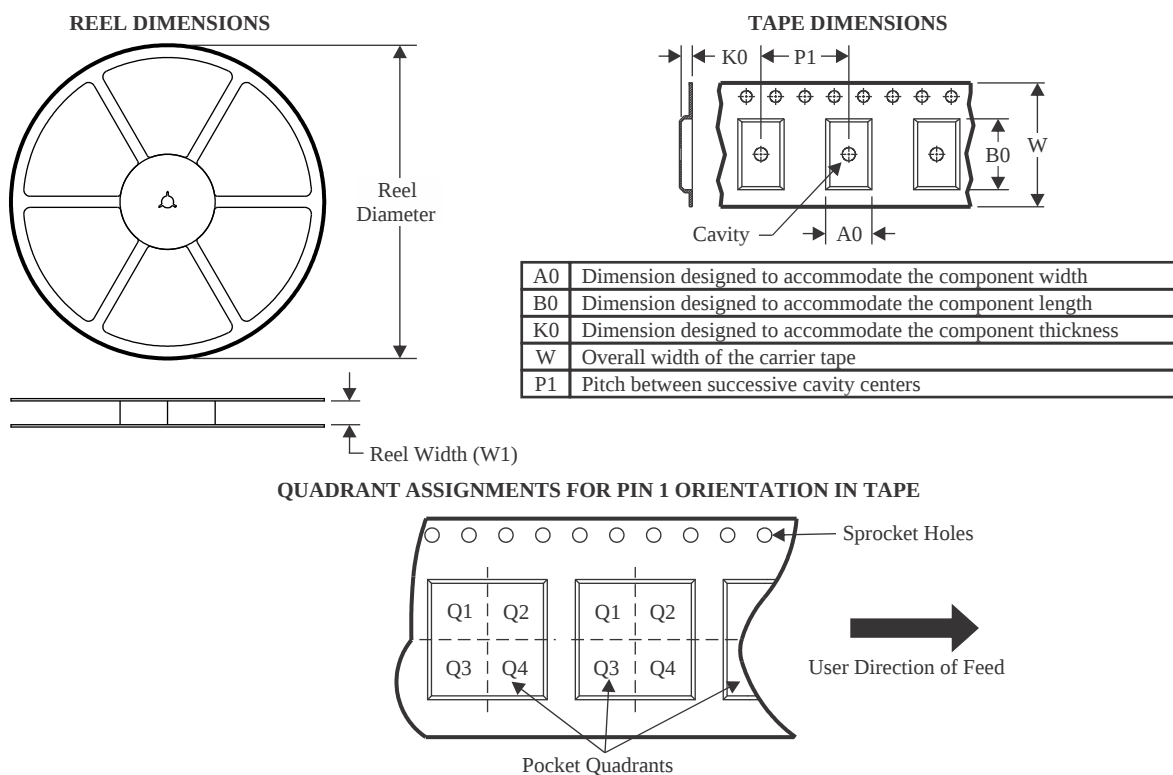
<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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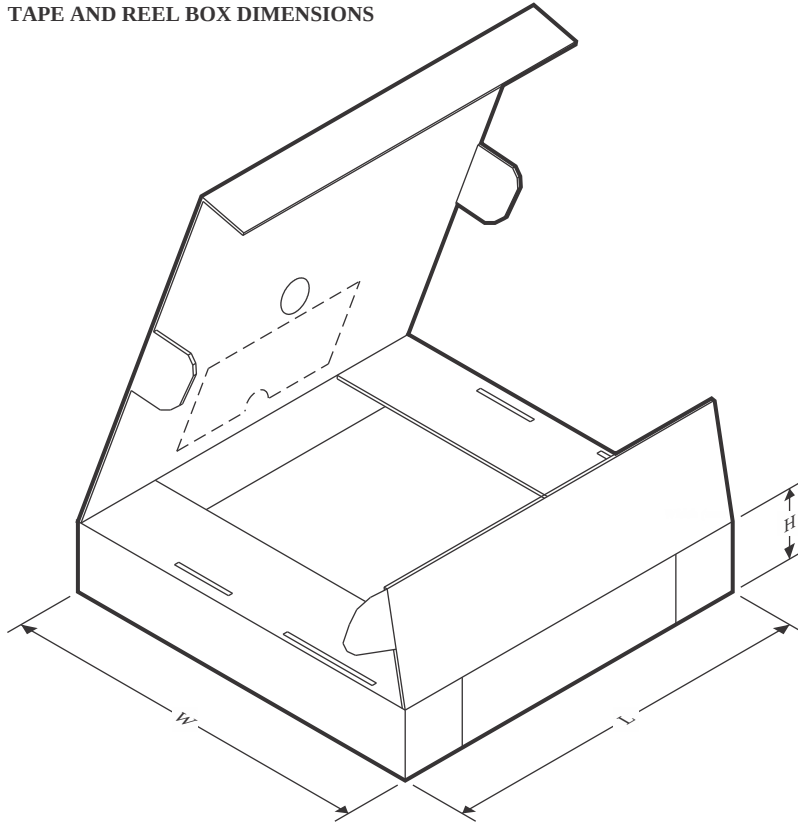
**TAPE AND REEL INFORMATION**


\*All dimensions are nominal

| Device               | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|----------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| LP2980AIM5-2.5/NOPB  | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5-3.0/NOPB  | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5-3.3/NOPB  | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5-4.7/NOPB  | SOT-23       | DBV             | 5    | 1000 | 178.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5-5.0/NOPB  | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5X-2.5/NOPB | SOT-23       | DBV             | 5    | 3000 | 178.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5X-3.0/NOPB | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5X-3.3/NOPB | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5X-4.7/NOPB | SOT-23       | DBV             | 5    | 3000 | 178.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980AIM5X-5.0/NOPB | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5-2.5/NOPB   | SOT-23       | DBV             | 5    | 1000 | 178.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5-3.0/NOPB   | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5-3.3/NOPB   | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5-3.8/NOPB   | SOT-23       | DBV             | 5    | 1000 | 178.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5-4.7/NOPB   | SOT-23       | DBV             | 5    | 1000 | 178.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5-5.0/NOPB   | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |

| Device              | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| LP2980IM5X-2.5/NOPB | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5X-3.0/NOPB | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5X-3.3/NOPB | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |
| LP2980IM5X-5.0/NOPB | SOT-23       | DBV             | 5    | 3000 | 180.0              | 8.4                | 3.2     | 3.2     | 1.4     | 4.0     | 8.0    | Q3            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device               | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|----------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| LP2980AIM5-2.5/NOPB  | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980AIM5-3.0/NOPB  | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980AIM5-3.3/NOPB  | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980AIM5-4.7/NOPB  | SOT-23       | DBV             | 5    | 1000 | 208.0       | 191.0      | 35.0        |
| LP2980AIM5-5.0/NOPB  | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980AIM5X-2.5/NOPB | SOT-23       | DBV             | 5    | 3000 | 208.0       | 191.0      | 35.0        |
| LP2980AIM5X-3.0/NOPB | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980AIM5X-3.3/NOPB | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980AIM5X-4.7/NOPB | SOT-23       | DBV             | 5    | 3000 | 208.0       | 191.0      | 35.0        |
| LP2980AIM5X-5.0/NOPB | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980IM5-2.5/NOPB   | SOT-23       | DBV             | 5    | 1000 | 208.0       | 191.0      | 35.0        |
| LP2980IM5-3.0/NOPB   | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980IM5-3.3/NOPB   | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980IM5-3.8/NOPB   | SOT-23       | DBV             | 5    | 1000 | 208.0       | 191.0      | 35.0        |
| LP2980IM5-4.7/NOPB   | SOT-23       | DBV             | 5    | 1000 | 208.0       | 191.0      | 35.0        |
| LP2980IM5-5.0/NOPB   | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980IM5X-2.5/NOPB  | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980IM5X-3.0/NOPB  | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |

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| Device              | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|---------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| LP2980IM5X-3.3/NOPB | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |
| LP2980IM5X-5.0/NOPB | SOT-23       | DBV             | 5    | 3000 | 210.0       | 185.0      | 35.0        |

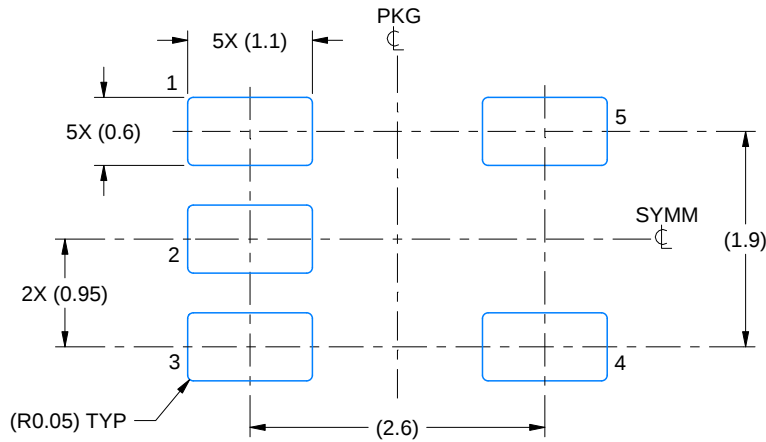


# EXAMPLE BOARD LAYOUT

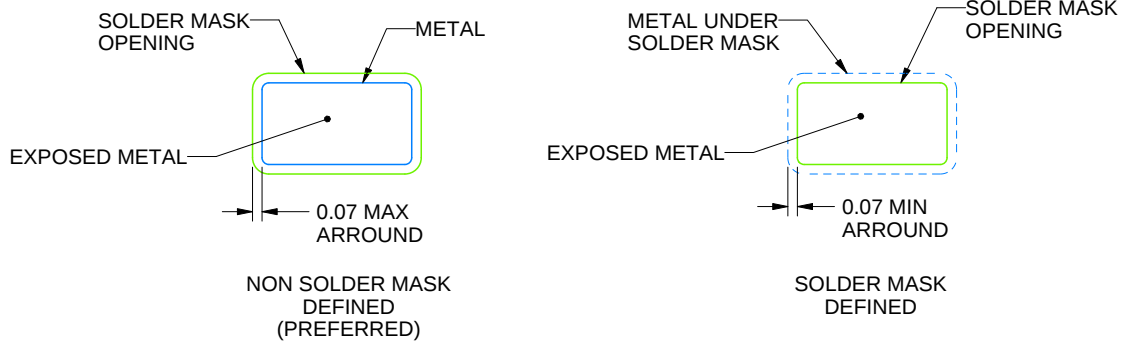
DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:15X



SOLDER MASK DETAILS

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NOTES: (continued)

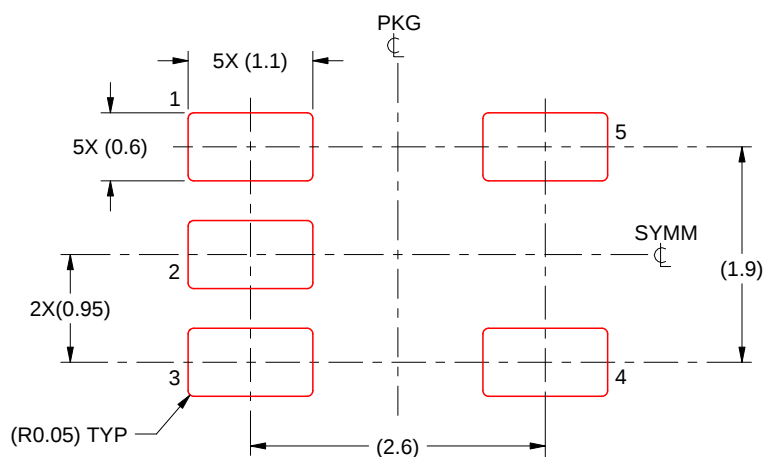
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:15X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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